

Notice of References Cited

Application/Control No.

10/528,848

Applicant(s)/Patent Under
Reexamination
HOSHINO ET AL.

Examiner

Scott D. Long

Art Unit

1633

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO02/00898	01-2002	Japan	Anazawa et al.	C12N 15/80
	O					
	P					
	Q					
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NON-PATENT DOCUMENTS

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